



IBM Haifa Leadership Seminar - Agenda

Software Testing Seminar 2004

December 23, 2004

09:00 Arrival	13:00 Lunch
09:20 Welcome David Bernstein, Manager, Software and Verification Technologies, IBM Haifa Labs	Session III: Industrial Experience, part 1
Session I: Multi-threading	14:00 Panel: What Makes a Testing Tool Usable Panelists: John Neystadt - Microsoft, Shmuel Bashan - Rational IBM, Shmuel Ur - Research IBM, Haim Arama - Tesnet
09:30 Thread Checker: Saving Valuable Time Otherwise Spent Searching for Hard-to-find Threading Errors Koby Gottlieb, Intel	15:00 Testing in Communication Satellite Amos 2 Arie Hopfeld, IAI
10:10 Tool-supported Methodology for Handling Multi-threaded Applications Eitan Farchi, IBM Haifa Labs	15:40 Break
10:45 Scaling Model Checking of Dataraces Using Dynamic Information Ohad Shacham, IBM Haifa Labs and Tel-Aviv University	Session IV: Industrial Experience, part 2
11:20 Break	16:00 Keyword-driven Testing Ayal Cohen & Tal Joseph, Mercury
Session II: Testing with AOP	16:40 Security Bulletins - Lessons Learnt, Changing the Way We Test Products and Patches John Neystadt, Microsoft
11:45 Aspects and Verification: Challenges and Opportunities Shmuel Katz, Technion	17:20 Concluding Remarks Orit Edelstein, IBM Haifa Labs
12:25 Multi-threaded testing with AOP is easy, and it finds bugs! Shady Coptly, IBM Haifa Labs	